

**Notice of References Cited**

Application/Control No.

10/564,313

Applicant(s)/Patent Under  
Reexamination  
FUKUI ET AL.

Examiner

HUY Q. PHAN

Art Unit

2617

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*	B	US-2005/0058154	03-2005	Lee et al.	370/473
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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